

Search Notes



Application/Control No.

10/822,252

Examiner

Anh V. La

Applicant(s)/Patent under Reexamination

MIAO

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	539.1 539.26 539.29	12/04/05	AL
	521		
	3.1		
	506		
	825.36		
	870.01		
	10.33		
	7.32		
	531		
	511		
701	117.29		
	273.14		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
consulted Benjamin Lee	11/07/05	AL
EAST	12/04/05	AL
PLUS	12/08/05	AL